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2	Brief Description of the Drawings
3	The features and advantages of a semiconductor device according to the
4	present invention and further details of a process of fabricating such a semiconductor
5	device in accordance with the present invention will be more clearly understood from the
6	following description taken in conjunction with the accompanying drawings in which like
7	reference numerals designate similar or corresponding elements, regions and portions and
8	in which:
9	Figures 1, 2, 3A, 4, 5, 6, 7, 8, 9 and 10 are cross sectional views for
10	illustrating a method for forming a capacitor and conductive lines according to an
11	embodiment of the present invention.
12	Figure 3B is a three dimensional view of the bottom plate with trenches
13	according to an embodiment of the invention.